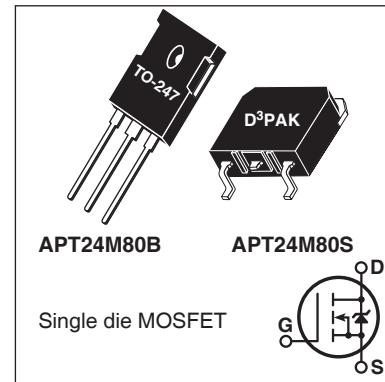


## N-Channel MOSFET

Power MOS 8™ is a high speed, high voltage N-channel switch-mode power MOSFET. A proprietary planar stripe design yields excellent reliability and manufacturability. Low switching loss is achieved with low input capacitance and ultra low  $C_{rss}$  "Miller" capacitance. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control slew rates during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency. Reliability in flyback, boost, forward, and other circuits is enhanced by the high avalanche energy capability.



## FEATURES

- Fast switching with low EMI/RFI
- Low  $R_{DS(on)}$
- Ultra low  $C_{rss}$  for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant 

## TYPICAL APPLICATIONS

- PFC and other boost converter
- Buck converter
- Two switch forward (asymmetrical bridge)
- Single switch forward
- Flyback
- Inverters

## Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
$I_D$	Continuous Drain Current @ $T_C = 25^\circ\text{C}$	24	A
	Continuous Drain Current @ $T_C = 100^\circ\text{C}$	15	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	85	
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulse Avalanche Energy <sup>②</sup>	975	mJ
$I_{AR}$	Avalanche Current, Repetitive or Non-Repetitive	12	A

## Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$			625	W
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.20	°C/W
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.11		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55		150	°C
$T_L$	Soldering Temperature for 10 Seconds (1.6mm from case)			300	
$W_T$	Package Weight		0.22		oz
			6.2		g
Torque	Mounting Torque (TO-247 Package), 6-32 or M3 screw			10	in-lbf
				1.1	N·m

## Static Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

APT24M80B\_S

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{BR(DSS)}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu\text{A}$	800			V
$\Delta V_{BR(DSS)}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}, I_D = 250\mu\text{A}$		0.87		$\text{V}/^\circ\text{C}$
$R_{DS(on)}$	Drain-Source On Resistance <sup>③</sup>	$V_{GS} = 10V, I_D = 12\text{A}$		0.35	0.43	$\Omega$
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1\text{mA}$	3	4	5	V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold Voltage Temperature Coefficient			-10		$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 800V, T_J = 25^\circ\text{C}$			100	$\mu\text{A}$
		$V_{GS} = 0V, T_J = 125^\circ\text{C}$			500	
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			$\pm 100$	nA

## Dynamic Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$g_{fs}$	Forward Transconductance	$V_{DS} = 50V, I_D = 12\text{A}$		21		S
$C_{iss}$	Input Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ $f = 1\text{MHz}$		4595		pF
$C_{rss}$	Reverse Transfer Capacitance			80		
$C_{oss}$	Output Capacitance			455		
$C_{o(cr)}^{\text{④}}$	Effective Output Capacitance, Charge Related	$V_{GS} = 0V, V_{DS} = 0V$ to 533V		215		pF
$C_{o(er)}^{\text{⑤}}$	Effective Output Capacitance, Energy Related			105		
$Q_g$	Total Gate Charge	$V_{GS} = 0$ to 10V, $I_D = 12\text{A}$ , $V_{DS} = 400V$		150		nC
$Q_{gs}$	Gate-Source Charge			25		
$Q_{gd}$	Gate-Drain Charge			75		
$t_{d(on)}$	Turn-On Delay Time	<b>Resistive Switching</b> $V_{DD} = 533V, I_D = 12\text{A}$ $R_G = 4.7\Omega^{\text{⑥}}$ , $V_{GG} = 15V$		26		ns
$t_r$	Current Rise Time			38		
$t_{d(off)}$	Turn-Off Delay Time			115		
$t_f$	Current Fall Time			33		

## Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$I_s$	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)			24	A
$I_{SM}$	Pulsed Source Current (Body Diode) <sup>①</sup>				85	
$V_{SD}$	Diode Forward Voltage	$I_{SD} = 12\text{A}, T_J = 25^\circ\text{C}, V_{GS} = 0V$			1.0	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 12\text{A}, V_{DD} = 100V^{\text{③}}$ $dI_{SD}/dt = 100\text{A}/\mu\text{s}, T_J = 25^\circ\text{C}$		880		ns
$Q_{rr}$	Reverse Recovery Charge			11		
$dv/dt$	Peak Recovery dv/dt	$I_{SD} \leq 12\text{A}, dI/dt \leq 1000\text{A}/\mu\text{s}, V_{DD} = 533V, T_J = 125^\circ\text{C}$			10	V/ns

① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

② Starting at  $T_J = 25^\circ\text{C}$ ,  $L = 13.54\text{mH}$ ,  $R_G = 10\Omega$ ,  $I_{AS} = 12\text{A}$ .

③ Pulse test: Pulse Width < 380μs, duty cycle < 2%.

④  $C_{o(cr)}$  is defined as a fixed capacitance with the same stored charge as  $C_{oss}$  with  $V_{DS} = 67\%$  of  $V_{(BR)DSS}$ .

⑤  $C_{o(er)}$  is defined as a fixed capacitance with the same stored energy as  $C_{oss}$  with  $V_{DS} = 67\%$  of  $V_{(BR)DSS}$ . To calculate  $C_{o(er)}$  for any value of  $V_{DS}$  less than  $V_{(BR)DSS}$ , use this equation:  $C_{o(er)} = 1.46E-8/V_{DS}^2 + 1.87E-8/V_{DS} + 7.21E-11$ .

⑥  $R_G$  is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

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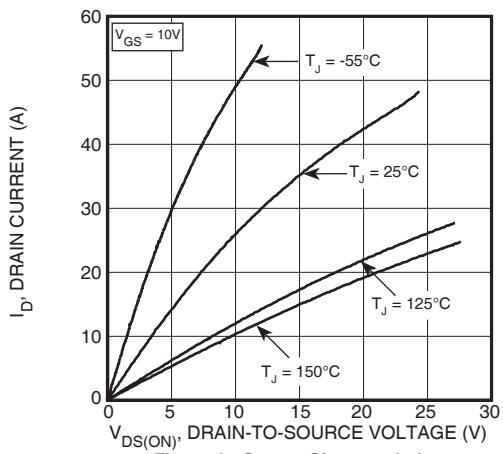


Figure 1, Output Characteristics

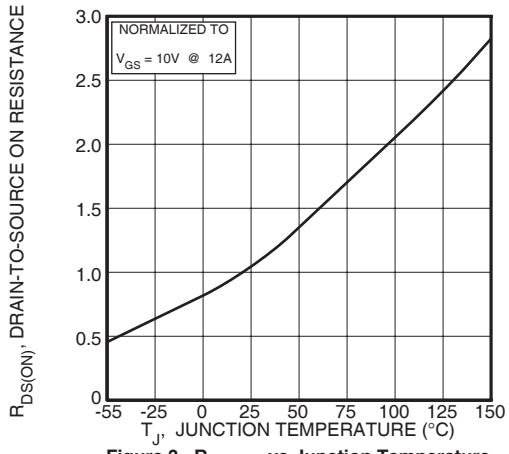


Figure 3,  $R_{DS(ON)}$  vs Junction Temperature

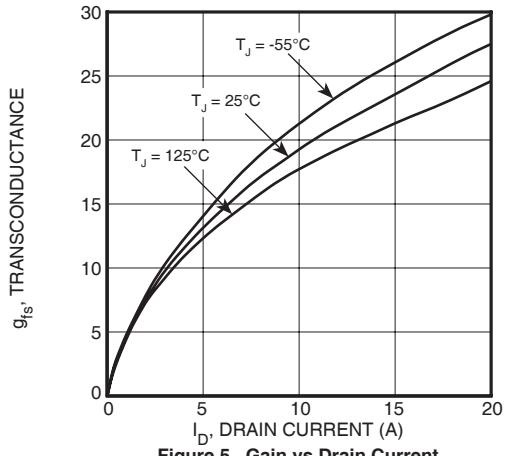


Figure 5, Gain vs Drain Current

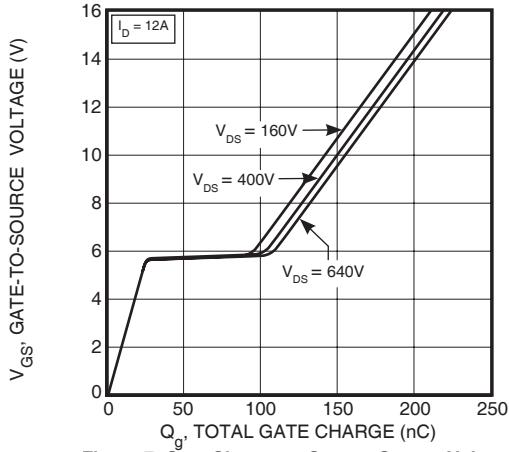


Figure 7, Gate Charge vs Gate-to-Source Voltage

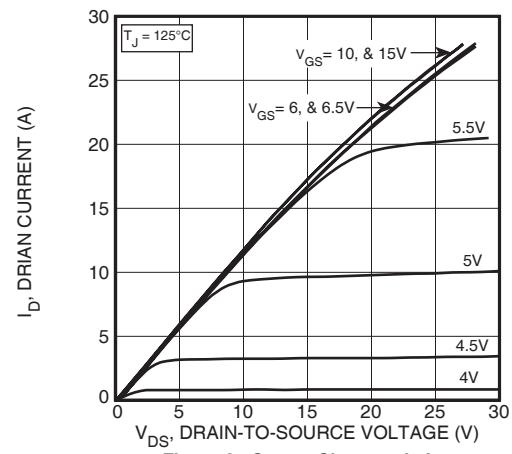


Figure 2, Output Characteristics

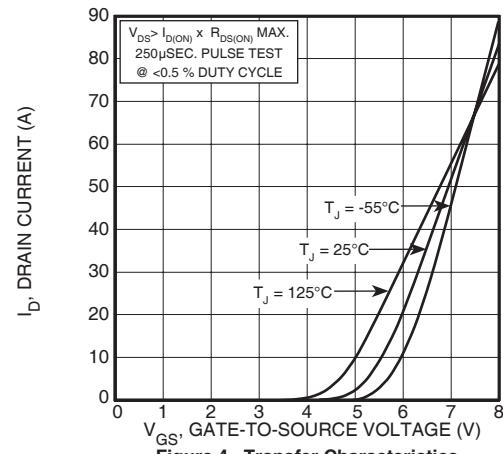


Figure 4, Transfer Characteristics

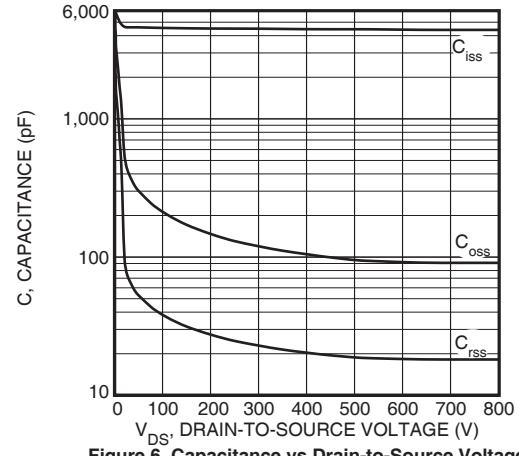


Figure 6, Capacitance vs Drain-to-Source Voltage

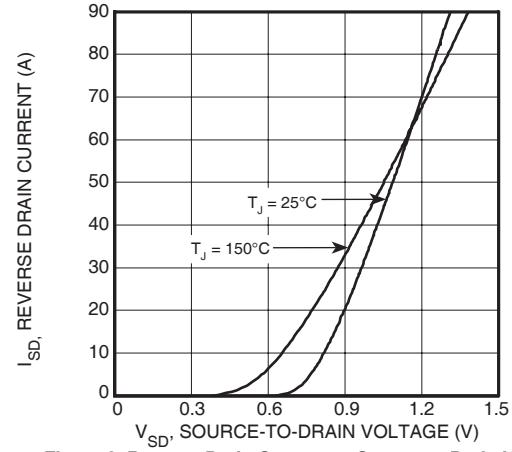


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage

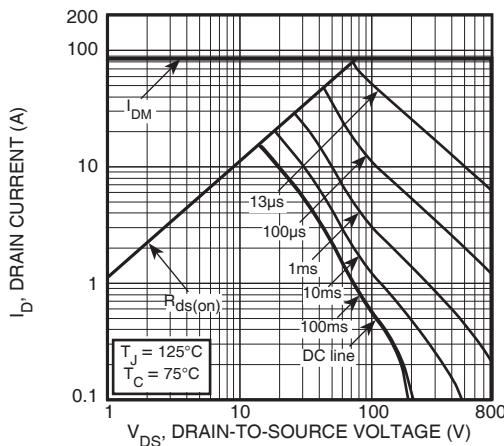


Figure 9, Forward Safe Operating Area

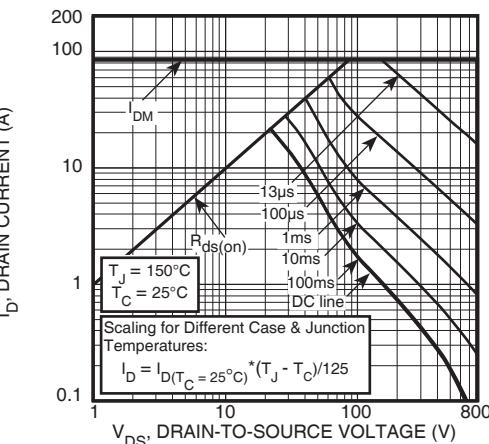


Figure 10, Maximum Forward Safe Operating Area

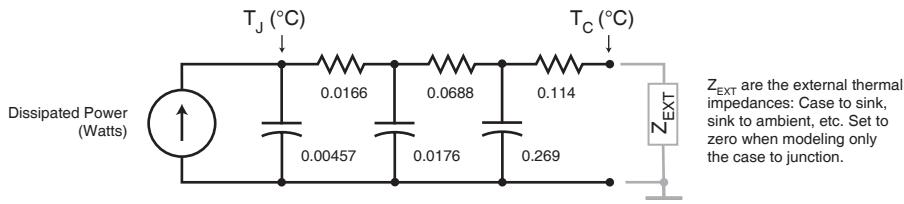


Figure 11, Transient Thermal Impedance Model

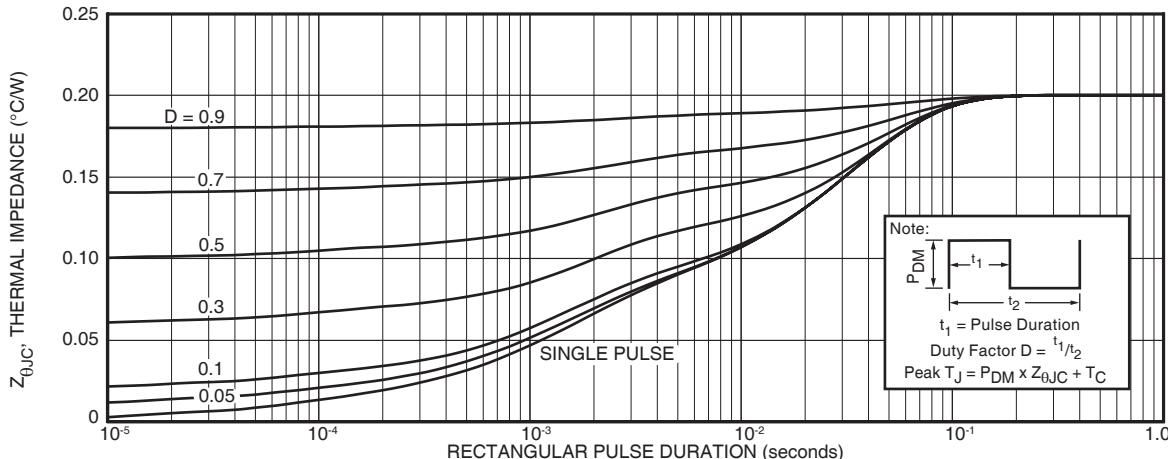
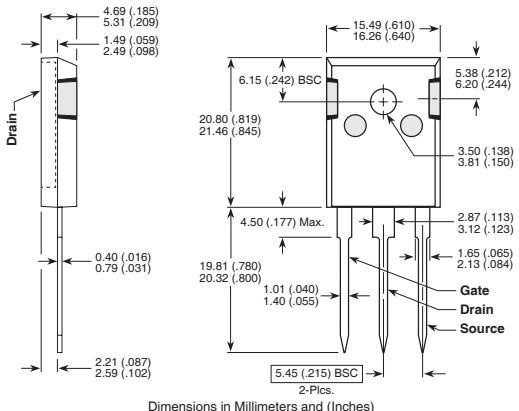


Figure 12. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

**TO-247 (B) Package Outline****D<sup>3</sup>PAK Package Outline**